

**Notice of References Cited**

Application/Control No.

09/574,900

Applicant(s)/Patent Under  
Reexamination  
MICHEL ET AL.

Examiner

Mehrdad Dastouri

Art Unit

2623

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,535,632	03-2003	Park et al.	382/164
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Schultz et al, "A Bayesian Approach to Image Expansion for Improved Definition", May 1994, IEEE transaction and Image Processing, Vol. 3, No. 3, Pages 233-242.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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